

<b>Notice of References Cited</b>	Application/Control No. 10/581,343		Applicant(s)/Patent Under Reexamination FUJIMARU ET AL.	
	Examiner SATYA B. SASTRI		Art Unit 1796	Page 1 of 1

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*	B	US-5,026,800	06-1991	Kimura et al.	526/200
*	C	US-4,587,308	05-1986	Makita et al.	525/373
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#### NON-PATENT DOCUMENTS

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	U	<a href="http://www.wovenwire.com/reference/particle-size.htm">http://www.wovenwire.com/reference/particle-size.htm</a>
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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